Search Notes					
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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/640,981	MITCHELL, MICHAEL LANE	
Examiner	Art Unit	
Hiep Nguyen	2816	

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
PG PUB,	Seach	07.05.06	M	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST	07-05-06	No		
See ablack ment	07.07.06	Br		
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